

Transaction Information

Tool ID	TST01_Prober
Tool Status	Running Wafers
Location	East Fishkill, USA
Wafer Size	300 mm
Fab Section	Test
Tool Available Date	2025-06-30

General Product Information

Vendor Supplier	TEL
Model	TEL Precio nano Prober
Vintage	2010
Serial No	PV00004
Asset Description	TEL Precio nano Prober TST01 Prober
Software Version	Standard
CIM	SECS GEM
Process	Test

Hardware Configuration (Fab)

System Type	Description	Quantity	Status
Main System	Main Tool ED05	1	OK
Handler System	Standard	1	OK
Factory Interface	FOUP	1	OK
Options System			

Hardware Configuration (Subfab / Auxilliary Units)

Description	Quantity	Status
NONE		

Missing/Faulty Parts / Accesories List

Description	Quantity
NONE	

Tool Pictures

General	Main tool
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General

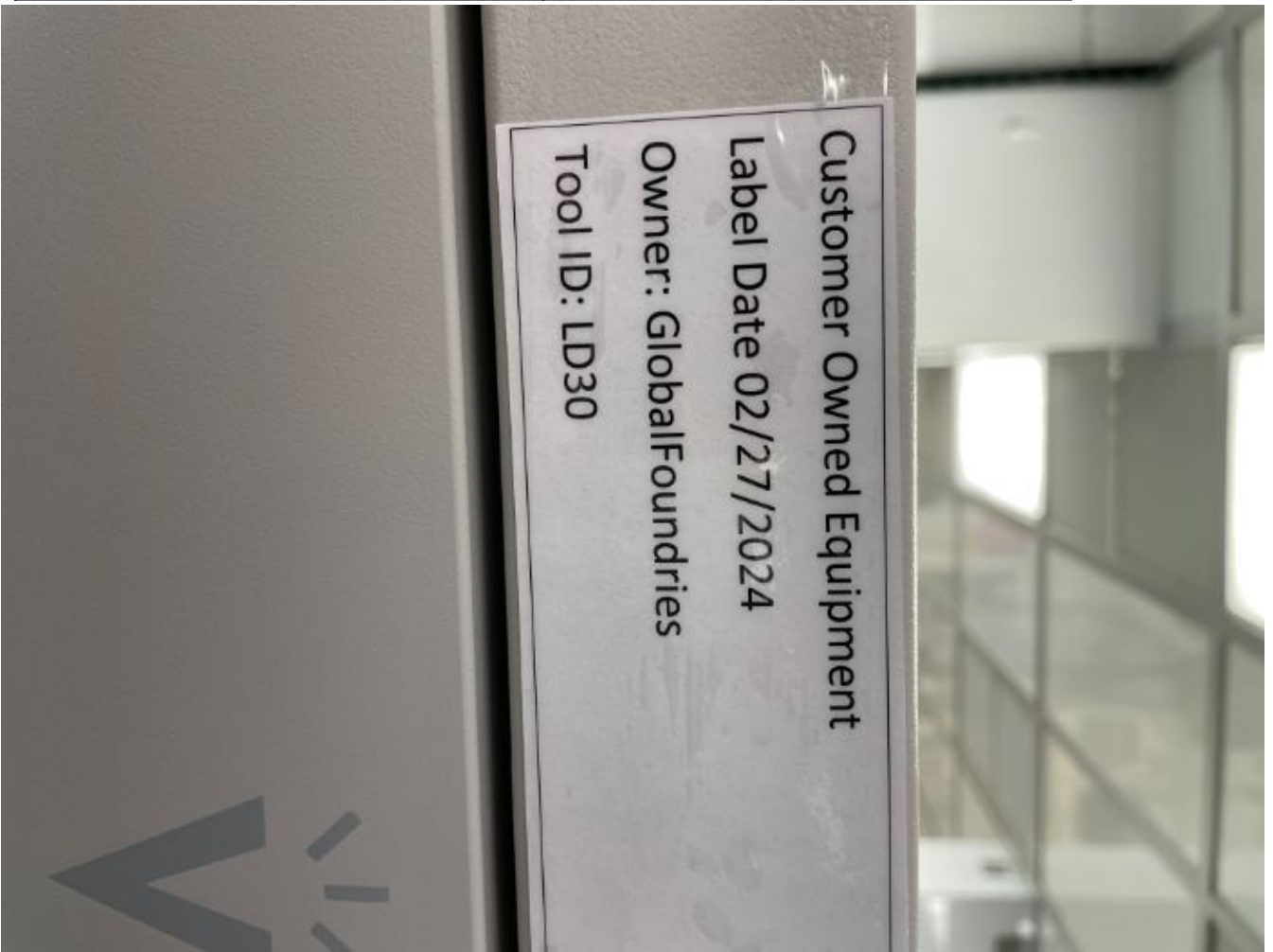
Main tool

Customer Owned Equipment

Label Date 02/27/2024

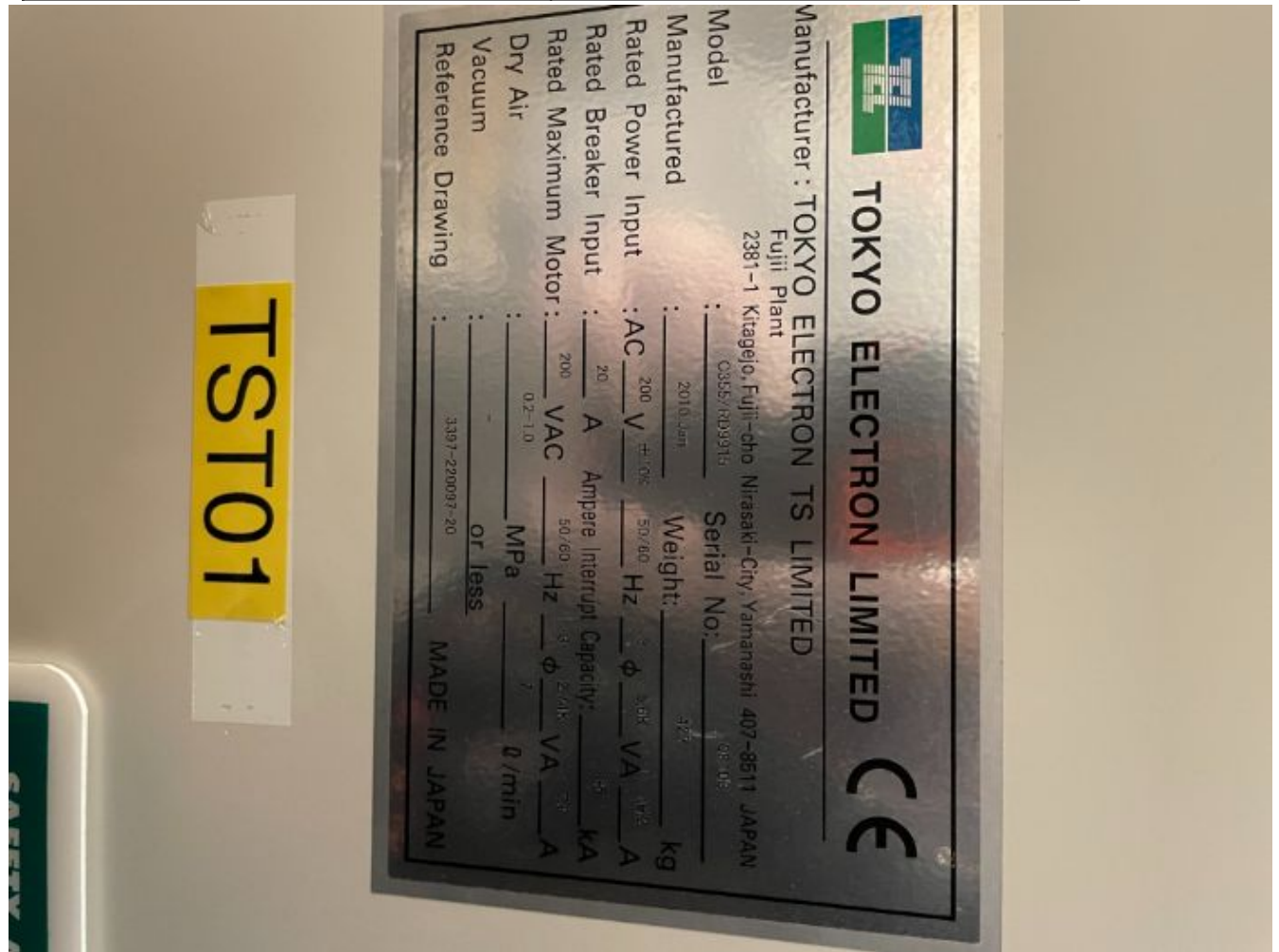
Owner: GlobalFoundries

Tool ID: LD30



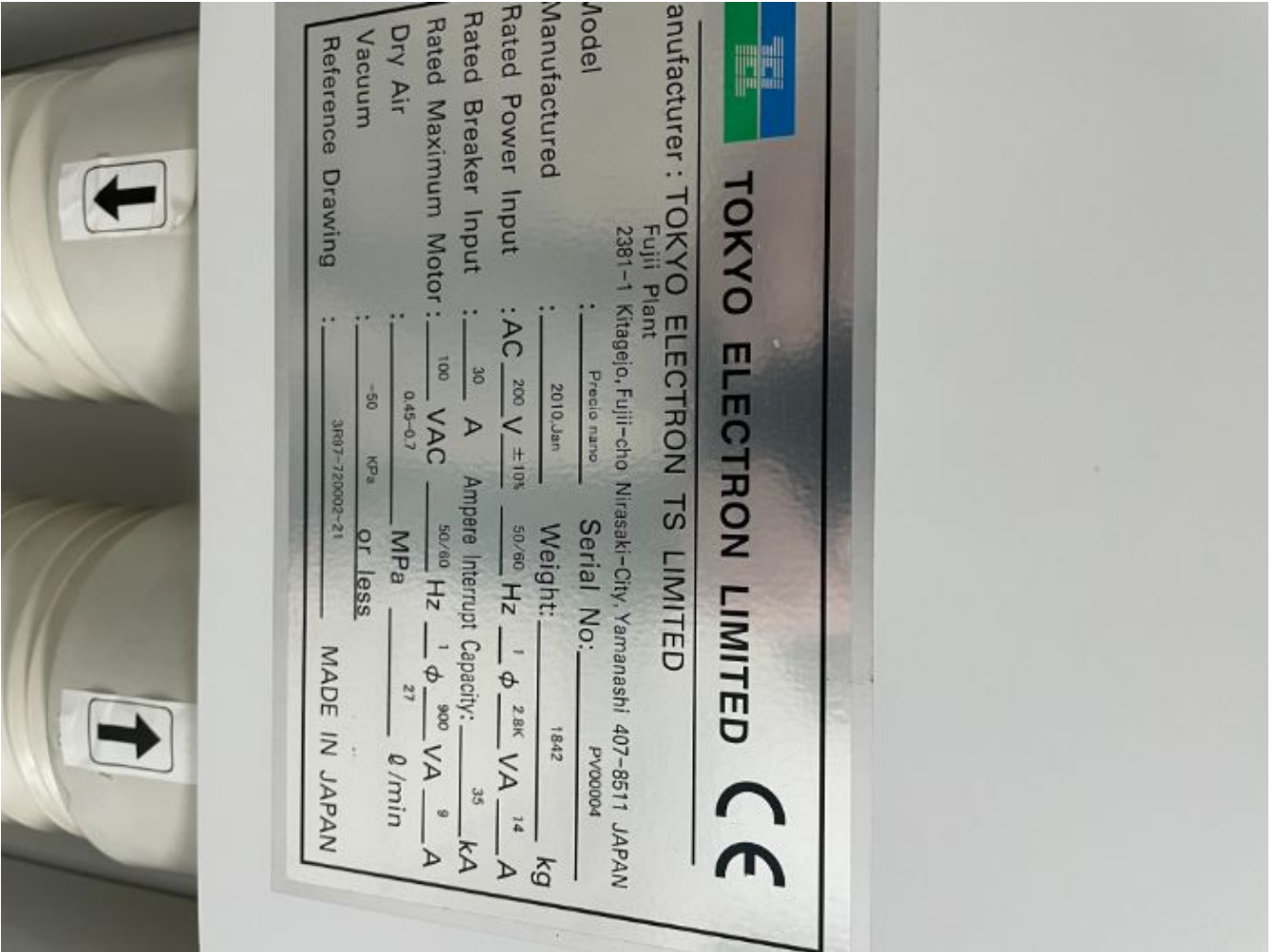
General

Main tool



Manufacture Serial

Serial Plate



Additional Configuration Files